Search Notes

Application/Control No.	rol No. Applicant(s)/Patent under Reexamination	
10/602,910	TAKAYAMA ET AL.	
Examiner	Art Unit	
 David M. Naff	1651	

SEARCHED						
Class	Subclass	Date	Examiner			
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INTERFERENCE SEARCHED						
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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